



SNIA Emerald™ Power Efficiency SNIA Emerald[™] Measurement Specification

Version 2.1.0

ABSTRACT: This Technical Position describes a standardized method to assess the energy efficiency of commercial storage products in both active and idle states of operation. A taxonomy is defined that classifies storage products in terms of operational profiles and supported features. Test definition and execution rules for measuring the power efficiency of each taxonomy category are described; these include test sequence, test configuration, instrumentation, benchmark driver, IO profiles, measurement interval, and metric stability assessment. Qualitative heuristic tests are defined to verify the existence of several capacity optimization methods. Resulting power efficiency metrics are defined as ratios of idle capacity or active operations during a selected stable measurement interval to the average measured power.

This document has been released and approved by the SNIA. The SNIA believes that the ideas, methodologies and technologies described in this document accurately represent the SNIA goals and are appropriate for widespread distribution. Suggestions for revision should be directed to http://www.snia.org/feedback/.

SNIA Technical Position

5/29/2015

USAGE

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Revision History

Revision	Release Date	Changes					
0.0.1	April 9, 2008	Initial Document Outline					
0.2.10	August 19, 2010	Public Review Draft					
0.3.20	May 24, 2011	SNIA Ballot Draft					
0.3.22	June 7, 2011	SNIA Ballot Draft					
1.0	August 23, 2011	Editorial work to format SNIA Technical Position					
2.0.0	Dec 12, 2012	Added Hot band workload definition, pre-fill, and adjusted test order for Online a Near-Online. Add definition of auto tiering. Editorial pass with changes to formatting, headings (division into more subsections), spelling, grammar, usage, check					
2.0.1	June 13, 2013	Incorporated changes to become a corrected SNIA Technical Position. (1) In 5.3, 5.4, 5.5, 5.56, changed "Max Config" to "Max Supported Config". (2) In 7.3.7, defined "Vdbench 5.04 or greater as the benchmark driver". Also added to B.2. (3) In 7.4.2, added "Tier Monitoring" as part of SUT Conditioning Test and added 7.4.2.2.1 as "Tiered Storage Data Migration Phase" as optional. (4) In 7.4.3.5, removed response time req'ts for Sequential loads, and will reduce RT(1800) for Random & Hot band workloads from 30ms to 20ms. Corrected Table 14 Corrected Tables 19, A-1, A-2. Revised details of snapshot heuristics 7.4.5.4.1 through 7.4.5.8. Revised Pre-fill Test Sections 7.4.1.1 and 7.4.1.2. Revised App. B Vdbench scripts					
2.0.2	August 12,2013	Working Draft. Vdbench scripts revised and referenced with URL, validity section revised to give user choice. Added that spec takes precedence over Script, "Example" back into headings re script files, Tables 11 & 12: added mandatory element from the script: skew.					
2.1.0	Nov. 19,2014	Editorial work throughout the specification. Combined Online and Near-Online test sections. Revised metric stability verification better defined requirements. Clarified the approved power meter list. Moved material from Annex B (Required Benchmark Driver) material to clause 7. Updated Vdbench material. Changed Annex C to Annex B and changed title to normative and updated test duration time. Added the 4KB table to the Variable IO section.					
2.1.0	Dec. 10, 2014	Editorial work on all subsections of 7.4.5 Capacity Optimization Test. Added a "container" definition to 7.4.5.2. Added pattern-oriented compressible data to compression data set and updated Table 17 in 7.4.5.3. Editorial changes to 7.4.5.4. Changed the Thin Provisioning test in 7.4.5.5. For sections 7.4.5.6 and 7.4.5.8 changed container size requirements and allow larger data sets using the irreducible data sets with different "salt" values					
2.1.0	May 29, 2015	Formatted as a SNIA Technical Position. Editorial typos corrected.					

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CONTACTING SNIA

SNIA Web Site

Current SNIA practice is to make updates and other information available through their web site at <u>http://www.snia.org</u>.

SNIA Emerald[™] Program Web Site

The SNIA Emerald[™] Program web site is <u>http://snia.org/emerald</u>. SNIA Emerald[™] Program-related downloads are available at <u>http://snia.org/emerald/download</u>, the *Documents and Downloads* web page.

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INTENDED AUDIENCE

This document is intended for use by individuals and companies engaged in assessing the power utilization of storage products.

CHANGES TO THE SPECIFICATION

Each publication of this specification is uniquely identified by a three-level identifier, comprised of a version number, a release number and an update number. The current identifier for this specification is version 2.1.0. Future publications of this specification are subject to specific constraints on the scope of change that is permissible from one publication to the next and the degree of interoperability and backward compatibility that should be assumed between products designed to different publications of this standard. The SNIA has defined three levels of change to a specification:

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- Minor Revision: A minor revision of the specification represents a technical change to existing content or an adjustment to the scope of the specification. A minor revision results in an increase in the release number of the specification's identifier (e.g., from x.1.x to x.2.x). Minor revisions with the same version number preserve interoperability and backward compatibility.
- Update: An update to the specification is limited to minor corrections or clarifications of existing specification content. An update will result in an increase in the third component of the release identifier (e.g., from x.x.1 to x.x.2). Updates with the same version and minor release levels preserve interoperability and backward compatibility.

Acknowledgements

The SNIA Green Storage Technical Working Group, which developed and reviewed this specification, would like to recognize the significant contributions made by the following members:

Dave Thiel, Consultant LLC	
Dell Computer Corp.	
EMC Corporation	Wayne Adams
	Jim Espy
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1 Overview

1.1 Preamble

There is a growing awareness of the environmental impact of IT equipment use. This impact takes several forms: the energy expended in equipment manufacture and distribution; the impact of materials reclamation, and the energy consumed in operation and cooling of the equipment. IT equipment users of all kinds now wish to make their IT operations as energy efficient as possible. This new priority can be driven by one or more of several requirements:

- Rising energy costs have made power and cooling expenses a more significant percentage of total cost of ownership of server and storage equipment.
- Some data centers are physically unable to add more power and cooling load, which means that new applications and data can only be brought on if old ones are retired or consolidated onto new, more efficient configurations.
- Increased regulatory and societal pressures provide incentives for companies to lower their total energy footprints. For many companies, IT is a significant portion of overall energy consumption, and corporate Green goals can only be achieved by reducing IT's energy needs or by making operations more efficient.

IT equipment users will seek advice on the most energy efficient approach to getting their work done. It is not practical for customers to test a wide range of storage products and architectures for themselves. A more effective approach is to create a collection of standard metrics that allow IT architects to objectively compare a range of possible solutions. This objective, metric-based approach has a dual impact:

- Users can select the mode of storage usage that accomplishes their work objectives with the lowest overall energy consumption.
- Companies will be driven to innovate and compete in the development of energy efficient products as measured by the standard yardsticks.

1.2 General Assumptions

The purpose of a SNIA Emerald[™] Power Efficiency Measurement is to provide a reproducible and standardized assessment of the energy efficiency of commercial storage products in both active and idle states. Tested systems shall:

- Be comprised of commercially released products and components.
- Employ settings, parameters, and configurations that would allow end-users to achieve power levels equivalent to the published result.

A SNIA Emerald[™] Power Efficiency Measurement is assumed to be a good faith effort to accurately characterize the power requirements of the tested system. The precise configuration used in a SNIA Emerald[™] Power Efficiency Measurement is left to the sponsor of a test. Any commercially released components may be used, and a focus on new or emerging components or technologies is encouraged.

1.3 Measurement Guidelines

SNIA Emerald[™] Power Efficiency Measurement Specification results are expected to be accurate and reproducible representations of storage product power efficiency. Therefore, stringent measurement guidelines are defined by this specification. They are intended to integrate with the auditing and reporting guidelines defined in the SNIA Emerald[™] Policies and Procedures, to provide the consumers of measurement data with a full, complete, accurate and verifiable assessment of a storage product's energy efficiency.

1.4 Terminology

This specification uses the term "efficiency" in two ways:

- The ratio of the energy supplied by a system (such as a power supply) to the energy supplied to it, usually expressed as a percentage (with an implicit maximum of 100%).
- The ratio of useful work to the energy required to do it, not expressed as a percentage.

The first definition is used when the numerator and denominator have the same units. The second definition, sometimes referred to as a productivity ratio, is used when the numerator and denominator have different units. In both cases, a larger value for the resultant ratio indicates higher efficiency.

1.5 Disclaimer

A SNIA Emerald[™] Power Efficiency Measurement result provides a high-level assessment of the energy efficiency of the tested system in specific idle and active states. It is not an attempt to precisely model or reproduce any specific installation.

Actual performance and energy consumption behavior is highly dependent upon precise workload, environmental and usage parameters. While SNIA Emerald[™] Power Efficiency Measurement results are intended to provide a realistic and reproducible assessment of the relative power efficiency of a system across a broad range of configurations and usage patterns, they cannot completely match the precise needs of any one specific installation.

2 Normative References

2.1 Overview

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

2.2 Approved references

Table 1 lists the standards, specifications and other documents that have been finalized and are referenced in this specification.

Author/Owner	Title	Revision	URL
American Society of Heating, Refrigerating and Air-Conditioning Engineers (ASHRAE)	Thermal Guidelines for Data Processing Environments	ISBN/ISSN: 1- 931862-43-5	http://www.ashrae.org/publication s/page/1900#thermalguidelines
Storage Networking Industry Association (SNIA)	Understanding Data Deduplication ratios		http://www.snia.org/sites/default/f iles/Understanding Data Dedupl ication_Ratios-20080718.pdf

Table 1 - Approved References

2.3 References under development

None defined in this specification.

2.4 Other references

gzip, a compression utility, can be downloaded at this website: http://www.gzip.org/.

3 Scope

3.1 Introduction

This specification defines methodologies and metrics for the evaluation of the related performance and energy consumption of storage products in specific active and idle states.

Storage products and components are said to be in an "active" state when they are processing externally initiated, application-level requests for data transfer between host(s) and the storage product(s). For purposes of this specification, idle is defined as "ready idle", in which storage systems and components are configured, powered up, connected to one or more hosts and capable of satisfying externally initiated, application-level initiated IO requests within normal response time constraints, but no such IO requests are being submitted.

3.2 Current Revision

This specification addresses block-mode access only. It is not appropriate to use this specification to ascertain power efficiency for anything other than block-mode access functionality. This specification includes:

- A generalized taxonomy for storage products (Section 5);
- An assessment mechanism for software-based Capacity Optimization Methods (Section 6);
- Measurement and data collection guidelines for assessing the power efficiency of block-oriented storage products in both active and ready idle states (Section 7);
- Metrics describing storage product power efficiency (Section 8).

3.3 Future Revisions

The SNIA has identified opportunities for refinement of existing material and expansion of scope that may be addressed in future revisions of the specification, including:

- Measurement, data collection guidelines and metrics for adjunct products and interconnect elements;
- Consideration of additional operational states (e.g., deep idle);
- Characterization of power supply efficiency;
- Revision and expansion of taxonomy to address additional products and market segments (e.g., filebased or object-oriented storage systems that provide interfaces other than block-mode access);
- Virtual media libraries that provide interfaces other than tape emulation;
- Assessment of power-related system functionalities and features;
- Measurement protocol for removable media mounts.

4 Definitions, Symbols, Abbreviations, and Conventions

4.1 Overview

The terms and definitions used in this specification are based on those found in the SNIA dictionary (<u>www.snia.org/education/dictionary</u>). They have been extended, as needed, for use in this specification. In cases where the current definitions in the SNIA dictionary conflict with those presented in this document, the definitions in this document shall be assumed to be correct.

4.2 Definitions

4.2.1

auto-tiering

Policy-based system that automatically places and moves data across tiers to optimize performance service levels, cost targets, and overall energy consumption.

Each storage tier may comprise different storage technologies, offering varying performance, cost, and energy consumption characteristics.

4.2.2

cache

Temporary storage used to transparently store data for expedited access to or from slower media, and not directly addressable by end-user applications.

4.2.3

capacity optimizing method (COM)

Any subsystem, whether implemented in hardware or software, which reduces the consumption of space required to store a data set.

4.2.4

capacity optimizing system (COS)

Any system that employs two or more COMs.

4.2.5

compression

The process of encoding data to reduce its size.

4.2.6

count-key-data (CKD)

A disk data organization model in which the disk is assumed to consist of a fixed number of tracks, each having a maximum data capacity.

The CKD architecture derives its name from the record format, which consists of a field containing the number of bytes of data and a record address, an optional key field by which particular records can be easily recognized, and the data itself.

4.2.7

data deduplication

The replacement of multiple copies of data—at variable levels of granularity—with references to a shared copy in order to save storage space and/or bandwidth.

4.2.8

delta snapshot

A type of point in time copy that preserves the state of data at an instant in time, by storing only those blocks that are different from an already existing full copy of the data.

4.2.9

direct-connected

Storage designed to be under the control of a single host, or multiple hosts in a non-shared environment.

4.2.10

file

An abstract data object made up of (a.) an ordered sequence of data bytes stored on a disk or tape, (b.) a symbolic name by which the object can be uniquely identified, and (c.) a set of properties, such as ownership and access permissions that allow the object to be managed by a file system or backup manager.

4.2.11

file system

A software component that imposes structure on the address space of one or more physical or virtual disks so that applications may deal more conveniently with abstract named data objects of variable size (files).

4.2.12

fixed block architecture (FBA)

A model of disks in which storage space is organized as linear, dense address spaces of blocks of a fixed size. Fixed block architecture is the disk model on which SCSI is predicated.

4.2.13

fixed content addressable Storage (FCAS)

Storage optimized to manage content addressable data that is not expected to change during its lifetime.

4.2.14

formatted capacity

The total amount of bytes available to be written after a system or device has been formatted for use, e.g., by an object store, file system or block services manager.

Formatted capacity, also called usable capacity, is less than or equal to raw capacity. It does not include areas set aside for system use, spares, RAID parity areas, checksum space, host- or file system-level remapping, "right sizing" of disks, disk labeling and so on. However, it may include areas that are normally reserved—such as snapshot set-asides—if they can alternatively be configured for ordinary data storage by the storage administrator.

Definitions, Symbols, Abbreviations, and Conventions

4.2.15

hot band

Simulation of naturally occurring hot spots.

4.2.16

hot spot

An area more frequently accessed across the addressable space of the storage product.

4.2.17

IO intensity

A measure of the number of IOPS requested by a benchmark driver.

IO intensity is phrased as a percentage of selected maximum IOPS level that satisfies the timing requirement(s) for a SUT's taxonomy category.

4.2.18

Logical Unit (LU)

The entity within a SCSI target that executes IO commands.

4.2.19

Logical Unit Number (LUN)

The logical unit indicated by the logical unit number.

4.2.20

Maximum Time to First Data (MaxTTFD)

The maximum time required to start receiving data from a storage system to satisfy a read request for arbitrary data.

4.2.21

network-connected

Storage designed to be connected to a host via a network protocol (e.g., TCP/IP, IB, and FC).

4.2.22

non-disruptive serviceability

Support for continued availability of data during all FRU service operations, including break/fix, code patches, software/firmware upgrades, configuration changes, data migrations, and system expansion.

Service operations may result in performance impacts to data availability, but shall not result in a loss of access.

4.2.23

parity RAID

A collective term used to refer to Berkeley RAID Levels 3, 4, 5 and 6.

4.2.24

raw capacity

The sum of the raw, unformatted, uncompressed capacity of each storage device in the SUT.

4.2.25

ready idle

An operational state in which a system is capable of satisfying an arbitrary IO request within the response time and MaxTTFD constraints of its selected taxonomy category, but no user-initiated IO requests are being submitted to the system.

4.2.26

sequential write

An IO load consisting of consecutively issued write requests to logically adjacent data.

4.2.27

Single Point of Failure (SPOF)

One component or path in a system, the failure of which would make the system inoperable or data inaccessible.

4.2.28

storage controller

A device for handling storage requests that includes a processor or sequencer programmed to autonomously process a substantial portion of IO requests directed to storage devices.

4.2.29

storage device

A collective term for disk drives, tapes cartridges, and any other mechanisms providing non-volatile data storage.

This definition is specifically intended to exclude aggregating storage elements such as RAID array subsystems, robotic tape libraries, filers, and file servers. Also excluded are storage devices which are not directly accessible by end-user application programs, and are instead employed as a form of internal cache.

4.2.30

storage product

The customer-orderable system or component that is the focal point of a SNIA Emerald[™] Power Efficiency Measurement; a central component of the SUT.

4.2.31

storage protection

Any combination of hardware and software (e.g., RAID, NVRAM, disk sparing and background disk scrubbing or media scan) that assures that all IO operations will be preserved in the event of power loss or storage device failure.

4.2.32

system under test (SUT)

The specific configuration of hardware and software used during a given SNIA Emerald[™] Power Efficiency Measurement.

4.2.33

test sponsor

The individual, company, or agent that submits a SNIA Emerald[™] Power Efficiency Measurement to SNIA.

4.2.34

thin provisioning

A technology that allocates the physical capacity of a volume or file system as applications write data, rather than pre-allocating all the physical capacity at the time of provisioning.

4.2.35

unused capacity

raw capacity that neither contributes to formatted capacity nor is set aside for system use, spares, RAID parity areas, checksum space, host- or file system-level remapping, "right sizing" of disks, disk labeling and so on.

4.2.36

virtual drive

A fixed, random access storage device that is emulating a removable media storage device (e.g., tape drive).

4.3 Acronyms and Abbreviations

FRU	Field-Replaceable Unit
IT	Information Technology
MAID	Massive Array of Idle Disks
RAS	Reliability, Availability, and Serviceability
SCSI	Small Computer System Interface
SNIA	Storage Network Industry Association
SUT	System under test
UPS	Uninterruptible Power Supply
A A Konne	rdo

4.4 Keywords

4.4.1

expected

A keyword used to describe the behavior of the hardware or software in the design models presumed by this standard. Other hardware and software design models may also be implemented.

4.4.2

mandatory

A keyword indicating an item that is required to be implemented as defined in this specification to claim compliance with this specification.

4.4.3

may

A keyword that indicates flexibility of choice with no implied preference.

4.4.4

may not

Keywords that indicate flexibility of choice with no implied preference.

4.4.5

obsolete

A keyword indicating that an item was defined in prior revisions to this specification but has been removed from this revision.

4.4.6

optional

A keyword that describes features that are not required to be operational during the test. However, if any optional feature is operational during the test, it shall be implemented as defined in this specification.

4.4.7

prohibited

A keyword used to describe a feature or behavior that is not allowed to be present in the SUT.

4.4.8

required

A keyword used to describe a behavior that shall be operational during of the test.

4.4.9

shall

A keyword indicating a mandatory requirement. Test sponsors are required to implement all such requirements.

4.4.10

should

A keyword indicating flexibility of choice with a preferred alternative; equivalent to the phrase "it is recommended".

4.5 Conventions

Certain words and terms used in this specification have a specific meaning beyond their normal English meaning. These words and terms are defined either in 4.2 or in the text where they first appear.

Numbers that are not immediately followed by lower-case b or h are decimal values.

Numbers immediately followed by lower-case b (xxb) are binary values.

Numbers immediately followed by lower-case h (xxh) are hexadecimal values.

Hexadecimal digits that are alphabetic characters are upper case (i.e., ABCDEF, not abcdef).

Hexadecimal numbers may be separated into groups of four digits by spaces. If the number is not a multiple of four digits, the first group may have fewer than four digits (e.g., AB CDEF 1234 5678h)

Storage capacities shall be reported in base-10. IO transfer sizes and offsets shall be reported in base-2. The associated units and abbreviations used in this specification are:

- A kilobyte (KB) is equal to 1,000 (10³) bytes.
- A megabyte (MB) is equal to 1,000,000 (10⁶) bytes.
- A gigabyte (GB) is equal to 1,000,000,000 (10⁹) bytes.
- A terabyte (TB) is equal to 1,000,000,000 (10¹²) bytes.
- A petabyte (PB) is equal to 1,000,000,000,000 (10¹⁵) bytes.
- An exabyte (EB) is equal to 1,000,000,000,000,000 (10¹⁸) bytes.
- A kibibyte (KiB) is equal to 2¹⁰ bytes.
- A mebibyte (MiB) is equal to 2²⁰ bytes.
- A gibibyte (GiB) is equal to 2³⁰ bytes.
- A tebibyte (TiB) is equal to 2⁴⁰ bytes.
- A pebibyte (PiB) is equal to 2⁵⁰ bytes.
- An exibyte (EiB) is equal to 2⁶⁰ bytes.

5 Taxonomy

5.1 Introduction

This clause defines a market taxonomy that classifies storage products or subsystems in terms of operational profile and supported features.

While this taxonomy is broad, and defines a framework for products that range from consumer solutions to enterprise installations, it is not intended to address all storage devices. For example, this taxonomy does not address storage devices that rely on a Universal Serial Bus (USB) connection for their power.

Further, while this document includes definitions for its entire taxonomy, it does not include testing methodologies for the entire taxonomy. Both individual sections of the taxonomy (e.g., Near-Online-1) and broader and more general groups of sections (e.g., Adjunct Product and Interconnect Element) are not addressed beyond taxonomy definition in this specification. Their cells in Table 2 are shaded to make it clear that this omission in intentional. The intent is to expand the specification to address these areas in detail in a later revision.

Category Level	Online (see 5.3)	Near- Online (see 5.4)	Removable Media Library (see 5.5)	Virtual Media Library (see 5.6)	Adjunct Product (see 5.7)	Interconnect Element (see 5.8)		
Consumer/ Component ^a	Online 1	Near- Online 1	Removable 1	Virtual 1	Not defined in this	Not defined in this		
Low-end	Online 2	Near- Online 2	Removable 2	Virtual 2	specification	specification		
Mid-range	Online 3	Near- Online 3	Removable 3	Virtual 3				
	Online 4							
High-end	Online 5	Near- Online 5	Removable 5	Virtual 5				
Mainframe	Online 6	Near- Online 6	Removable 6	Virtual 6				
^a Entries in this level of taxonomy include both consumer products and data-center components								

Table 2 - Taxonomy Overview

^a Entries in this level of taxonomy include both consumer products and data-center components (e.g., stand-alone tape drives)

5.2 Taxonomy Assumptions

5.2.1 Taxonomy Categories

Taxonomy categories define broad market segments that can be used to group products that share common functionality or performance requirements, and within which meaningful product comparison can be undertaken. This specification defines six broad taxonomy categories (summarized in Table 2):

- Online, defined in 5.3;
- Near-Online, defined in 5.4;
- Removable Media Library, defined in 5.5;
- Virtual Media Library, defined in 5.6;
- Adjunct Product, defined in 5.7;
- Interconnect Element, defined in 5.8.

Within a taxonomy category, a specific model or release of a product will support different feature sets, whether focused on capacity, reliability, performance, functionality or another differentiator. Feature and functionality differences within a category are addressed with attributes. Each taxonomy category defines a set of attributes that are common to all products within the category.

5.2.2 Category Attributes

Where a taxonomy category requires a specific, fixed setting or range for a given attribute, that setting is summarized in Table 3 to assist a test sponsor in initial category selection. The full set of attributes for each category is provided in Sections 5.3 through 5.8.

Attribute	Category						
	Online	Near- Online	Removable Media Library	Virtual Media Library	Adjunct Product	Interconnect Element	
Access Pattern	Random/ Sequential	Random/ Sequential	Sequential	Sequential			
MaxTTFD (t) ^a	t < 80 ms	t > 80 ms	t > 80 ms t < 5 min	t < 80 ms	t < 80 ms	t < 80 ms	
User Accessible Data	Required	Required	Required	Required	Prohibited	Prohibited	
^a For the Adjunct	Product and Inte	arconnect Ele	ment categori	as MayTTED m	ageuros tha	maximum	

 Table 3 - Common Category Attributes

^a For the Adjunct Product and Interconnect Element categories, MaxTTFD measures the maximum additional latency introduced by the product.

Classifications define combinations of settings or values for the attributes within a category.

A product shall satisfy all the attributes for its designated category and designated classification. In cases where storage devices within a SUT fall within more than one category or classification, the SUT is defined to be a member of the category and classification whose requirements can be met by all of its storage devices.

Maximum Configuration bounds the number of storage devices that the product is capable of supporting.

5.3 Online Category

This category defines the features and functionalities for an online, random-access storage product. Products in this profile may provide any combination of block, file or object interfaces. Table 4 defines the requirements for the taxonomy classifications defined in this category.

	Classification							
Attribute	Online 1	Online 2	Online 3	Online 4	Online 5	Online 6		
Access Pattern	Random/ Sequential	Random/ Sequential	Random/ Sequential	Random/ Sequential	Random/ Sequential	Random/ Sequential		
MaxTTFD (t)	t < 80 ms	t < 80 ms	t < 80 ms	t < 80 ms	t < 80 ms	t < 80 ms		
User-Accessible Data	Required	Required	Required	Required	Required	Required		
Connectivity	Not specified	Connected to single or multiple hosts	Network- connected	Network- connected	Network- connected	Network- connected		
Consumer/ Component	Yes	No	No	No	No	No		
Integrated Storage Controller	Optional	Optional	Required	Required	Required	Required		
Storage Protection	Optional	Optional	Required	Required	Required	Required		
No SPOF	Optional	Optional	Optional	Required	Required	Required		
Non-Disruptive Serviceability	Optional	Optional	Optional	Optional	Required	Required		
FBA/CKD Support	Optional	Optional	Optional	Optional	Optional	Required		
Maximum Supported Configuration	≥1	≥ 4	≥ 12	> 100	>400	>400		

Table 4 - Online Classifications

5.4 Near-Online Category

This category defines the features and functionalities for a near-online, random-access storage product. Products in this profile employ MAID or FCAS architectures as well as any combination of block, file or object interfaces. Table 5 defines the requirements for this taxonomy classifications defined in this category.

Attribute	Classification							
Attribute	Near- Online 1	Near- Online 2	Near- Online 3	Near- Online 4	Near- Online 5	Near- Online 6		
Access Pattern	Random/ Sequential	Random/ Sequential	Random/ Sequential		Random/ Sequential	Random/ Sequential		
MaxTTFD (t)	t > 80 ms	t > 80 ms	t > 80 ms		t > 80 ms	t > 80 ms		
User-accessible Data	Required	Required	Required		Required	Required		
Connectivity	Not specified	Network connected	Network connected		Network connected	Network connected		
Consumer/ Component	Yes	No	No		No	No		
Integrated Storage Controller	Optional	Optional	Required		Required	Required		
Storage Protection	Optional	Optional	Required		Required	Required		
No SPOF	Optional	Optional	Optional		Optional	Required		
Non-Disruptive Serviceability	Optional	Optional	Optional		Optional	Required		
FBA/CKD Support	Optional	Optional	Optional		Optional	Optional		
Maximum Supported Configuration	≥1	≥ 4	≥ 12		> 100	> 1000		

Table 5 – Near-Online Classifications

5.5 Removable Media Library Category

This category defines the features and functionalities for storage products that rely on automated or manual media loaders (e.g., tape or optical libraries). Table 6 defines the requirements for the taxonomy classifications defined in this category.

Attribute	Classification								
	Removable 1	Removable 2	Removable 3	Removable 4	Removable 5	Removable 6			
Access Pattern	Sequential	Sequential	Sequential		Sequential	Sequential			
MaxTTFD (t)	80ms < t < 5m	80ms < t < 5m	80ms < t < 5m		80ms < t < 5m	80ms < t < 5m			
User-Accessible Data	Required	Required	Required		Required	Required			
Robotics	Prohibited	Required	Required		Required	Required			
No SPOF	Optional	Optional	Optional		Optional	Required			
Non-disruptive Serviceability	Optional	Optional	Optional		Optional	Required			
Maximum Supported Drive Count	Not specified	4	≥5		≥ 25	≥ 25			

Table 6 - Removable Media Library Classifications

5.6 Virtual Media Library Category

This operational profile defines the features and functionalities for sequential-access storage products that rely on non-removable storage media to provide a Virtual Media Library. Table 7 defines the requirements for the taxonomy classifications defined in this category.

Attribute	Classification						
Allfibule	Virtual 1	Virtual 2	Virtual 3	Virtual 4	Virtual 5	Virtual 6	
Access Pattern	Sequential	Sequential	Sequential		Sequential	Sequential	
MaxTTFD (t)	t < 80 ms	t < 80 ms	t < 80 ms		t < 80 ms	t < 80 ms	
User- accessible Data	Required	Required	Required		Required	Required	
Storage Protection	Optional	Optional	Required		Required	Required	
No SPOF	Optional	Optional	Optional		Optional	Required	
Non-Disruptive Serviceability	Optional	Optional	Optional		Optional	Required	
Maximum Supported Configuration	12	>12	> 48		> 96	> 96	

5.7 Adjunct Product Category

This operational profile defines the features and functionalities for products that support a storage area network and provide advanced management capabilities. Products in this category rely on a closed environment to typically support a single-purpose, dedicated storage-oriented service or application (e.g., virtualization, deduplication, NAS gateways). No end-user-accessible data is stored in the product across power cycles (though some data may be cached during a given operational period). Devices in this category are part of the data path from a host to a storage device, and are responding to IO requests in real time. Products that are outside the data path (e.g., backup servers) are not addressed by this category.

5.8 Interconnect Element Category

This operational profile defines the features and functionalities for managed inter-connect elements within a storage area network (e.g., switches, extenders).

6 Capacity Optimization

6.1 Introduction

Hardware efficiencies are essential for reducing the amount of power used by storage, but equally real savings are obtained by capacity optimization. Capacity optimization refers to a set of techniques which collectively reduce the amount of storage necessary to meet storage objectives. Reduced use of storage (or increased utilization of raw storage) will result in less energy usage for a given task or objective.

Each of these techniques is known as a capacity optimizing method (COM). The COMs are largely, though not completely, independent. In other words, they provide benefit in any combination, though their combined effect may not precisely equal the sum of their individual impacts. Nonetheless, since data sets vary greatly, a hybrid approach using as many techniques as possible is more likely to minimize the capacity requirements of any given data set, and therefore is also likely to achieve the best results over the universe of data sets. In addition, the space savings achievable through the different COMs are sufficiently close to one another that they may be considered roughly equivalent in storage capacity impact.

6.2 Space Consuming Practices

A central assumption of this arena is that certain space consuming practices are essential to the storage of data at a data center class service level:

- Disk-based redundancy. When one or more drives (or other storage devices) fail—the number depending on service level—no interruption in service or loss of data may occur;
- Sufficient space. An application shall have enough space provisioned for it, so that no downtime shall be incurred during normal operation;
- Point-In-Time (PIT) copy availability. Data center applications under test need access to PIT copies of data sets that they can manipulate without fear of interference with live data;
- Disaster recovery. When data corruption or loss does occur, good copies of the data must be available to restore service.

6.3 COMs Characterized

In this specification, the following COMs are characterized:

- **Delta Snapshots**: applicable to backup, PIT copy availability and disaster recovery. Both read-only and writeable delta snapshots are featured in shipping systems, but there are fundamental technical differences between them, and some systems implement only the read-only version.
- **Thin Provisioning**: primarily addresses over-provisioning caused by the requirement for a guarantee of no out-of-space errors.
- **Data Deduplication:** addresses issues caused by multiple backups of the same data sets, and the tendency of large data sets, due to human usage patterns, to contain many copies of the same data (not necessarily on file boundaries).
- **Parity RAID:** addresses the need for disk-based redundancy. In this document the term *Parity RAID* simply means any RAID system that achieves better efficiency than RAID 1.
- Compression: takes advantage of the inherent compressibility of many data sets.

7 Test Definition and Execution Rules

7.1 Overview

This clause defines the data collection and testing methodology used to produce a valid SNIA Emerald[™] Power Efficiency Measurement. The data collected using the procedures defined in this clause becomes the basis for the metrics defined in Clause 8.

7.2 Execution Overview

A SNIA Emerald[™] Power Efficiency Measurement consists of a sequence of tests:

- 1. Pre-fill test, which puts data on the SUT;
- 2. SUT conditioning test, which assures accurate and reproducible measurements;
- 3. Active test, the basis for the active metrics;
- 4. Ready idle test, the basis of the idle metric;
- 5. Capacity optimization test (if defined), the basis of the secondary, capacity optimization metrics.

Some tests involve a timed sequence of defined measurements taken over defined intervals. Tests may have subordinate test phases as well. Sections 7.4, 7.5, 7.6, 7.7, and 7.8 detail the precise requirements for completing a given test for each taxonomy category, as well as any subordinate test phases defined within a given test. A valid measurement shall adhere to all requirements that are specific to the taxonomy category selected for the result (see 7.3.2) as well as any general requirements for test execution (see 7.3).

7.3 General Requirements and Definitions

7.3.1 Configuration Guidelines

This specification does not constrain the precise configuration and interconnection of the hardware necessary to complete a SNIA Emerald[™] Power Efficiency Measurement. Figure 1 is provided as a guideline, but test sponsors are free to modify their configuration to suit their particular needs and equipment, provided no other requirement of this specification is violated.

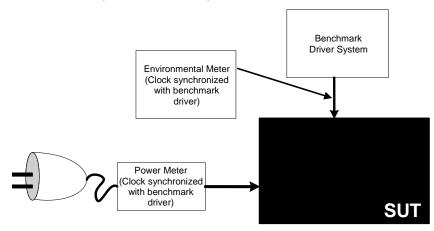


Figure 1 - Sample Configuration

7.3.2 SUT Configuration

The test sponsor shall identify one taxonomy classification for the SUT.

The SUT shall be configured to satisfy the requirements of the selected taxonomy classification.

The SUT shall represent a customer orderable configuration whose use within the selected taxonomy category is supported by the test sponsor.

For a SUT in the Removable Media Library category, all drives must provide the same stated maximum data rate.

7.3.3 Power

The power supplied to the SUT shall match one of the power profiles outlined in Table 8, differing from the stated voltage boundaries by not more than 10%.

NOMINAL INPUT VOLTAGE RANGE	Phases	AC INPUT FREQUENCY RANGE
100 – 120 VAC RMS	1	47 – 63 Hz
200 – 240 VAC RMS	1	47 – 63 Hz
200 – 480 VAC RMS	3	47 – 63 Hz

 Table 8 - Input Voltage Ranges

The power supplied to the SUT shall conform to the selected profile throughout test execution.

Any batteries present in the SUT shall be fully charged at the start of testing.

7.3.4 Environmental

All measurements shall be conducted in a climate-controlled facility.

Environmental conditions that satisfy ASHRAE Class I standards for data centers (as described in *Thermal Guidelines for Data Processing Environments*) shall be maintained throughout test execution.

7.3.5 Instrumentation

The benchmark configuration shall include a recommended power meter (sometimes called an *analyzer*). If the selected power meter does not gather environmental data, the benchmark configuration shall include an environmental meter. See Annex A for information regarding recommended meters.

The power meter shall be active throughout all tests and test phases of the benchmark and shall record:

- Input voltage to the SUT, to an accuracy of 1%;
- Power consumption by the SUT, to the accuracy summarized in Table 9.

The power and voltage measurements shall be recorded to durable media using a period of not more than 5 seconds and shall use a timestamp that is synchronized with the other components of the SUT to a resolution of at least 1 second.

Power Consumption (p)	Minimum Accuracy
p ≤ 10 W	± 0.01 W
10 < p ≤ 100 W	± 0.1 W
p > 100 W	± 1.0 W

Table	9 -	Power	Meter	Accuracy	V
-------	-----	-------	-------	----------	---

The temperature, measured in degrees C, to a resolution of 0.1 degree, as measured at the primary air inlet port for the SUT, shall be recorded to durable media using a period of not more than one minute.

7.3.6 RAS

RAS features can have a significant impact on the power consumption of the SUT. Typical RAS features are summarized in Table 10.

·
Example RAS Features
Dual Controller (No SPOF Controller)
Mirroring (Local or remote, sync or async)
RAID 1, 4/5, 6
Snapshots (Full or Delta)
Disk Scrubbing
Multi-pathing
Disk Sparing
Dual Robotics
Drive-level Maintenance
Dual Power Supply
Variable-speed Fans

Table 10 - Example RAS Features

Any RAS features required to satisfy the requirements of the selected taxonomy category shall be enabled. The choice of what additional RAS features to enable in a SUT is left to the test sponsor.

If the SUT includes RAS features that are enabled for any test or test phase, then they shall be enabled for all tests and test phase, unless disabling of RAS features is explicitly allowed in the definition of a given test or test phase.

7.3.7 Benchmark Driver

The required benchmark driver for use in SNIA Emerald[™] Power Efficiency Measurement Specification measurements is Vdbench 5.04 or later, available at the SNIA website, <u>http://sniaemerald.com/download.</u>

Test sponsors shall use the Vdbench script located at <u>http://sniaemerald.com/download</u>. The script contains user adjustable parameters.

This specification takes precedence over any script if there is a conflict.

7.3.8 IO Profiles

7.3.8.1 Overview

The particular IO stimuli required during a test or test phase are specified in terms of an IO profile (a.k.a. workload) made up of seven attributes:

- Name: the name of the IO pattern for this stimulus. The identifier for the associated test phase is included parenthetically, when appropriate;
- IO Size: the number of bytes requested by a given read or write operation;
- Read/Write Percentage: the mixture of read/write IO requests within an IO profile;

- Transfer Alignment: Minimum granularity of IO transfer addresses. All transfer addresses within an IO stream shall be a multiple of this value.
- Access Pattern: one of
 - Random: Randomly distributed throughout the formatted capacity of the SUT, and rounded down to satisfy the Transfer Alignment requirement;
 - Sequential, as defined in 4.2.

7.3.8.2 Sequential Access

The first IO within an IO Stream with a sequential access pattern shall use an offset randomly distributed throughout the address range provided to the benchmark driver, and rounded down to satisfy the Transfer Alignment requirement. Each subsequent IO request shall be sent to and satisfied by the SUT in sequence using an offset that satisfies Equation 7-1.

Equation 7-1: Sequential Transfer Offset

$$O_{n+1} = (O_n + S) MOD R$$

Where:

- On is an IO offset;
- S is the IO size;
- R is the formatted capacity of the SUT.

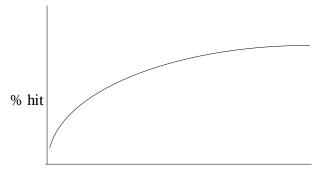
7.3.8.3 Hot Band IO Profile

7.3.8.3.1 Overview

The goal of the hot band IO profile is to provide a workload that considers the contribution of tiering mechanisms, e.g., read caching. This workload consists of a mix of different IO sizes and access patterns with a skewed access across a range of blocks. For example, this skewed access tends to hold data in cache and creates "cache hits" for improved throughput and reduced power consumption.

7.3.8.3.2 Exponential Access Pattern

Within a hot band, the probability of block access is skewed. Not all blocks are accessed equally. For example, this can result in an access pattern that creates a cache-friendly workload. The larger the cache size, the better the cache hit rate, as shown in Figure 2.



Cache size

Figure 2 - Percentage of Address Hit vs. Cache Size

7.3.8.3.3 Workloads within the Hot Band IO Profile

Table 11 shows information concerning workloads within the hot band IO profile.

IO Profile	% of workload (Vdbench skew)	Read/Write Percentage	IO Size (KiB)	Access Pattern	Usable Address Range
Write Stream 1	5	0/100	See Table 12	Sequential	0-100%
Write Stream 2	5	0/100	See Table 12	Sequential	0-100%
Write Stream 3	5	0/100	See Table 12	Sequential	0-100%
Read Stream 1	5	100/0	See Table 12	Sequential	0-100%
Read Stream 2	5	100/0	See Table 12	Sequential	0-100%
Read Stream 3	5	100/0	See Table 12	Sequential	0-100%
Read Stream 4	5	100/0	See Table 12	Sequential	0-100%
Read Stream 5	5	100/0	See Table 12	Sequential	0-100%
Uniform Random	6	50/50	See Table 12	Random	0-100%
Hot Band 1	28	70/30	See Table 12	Random	10 -18%
Hot Band 2	14	70/30	See Table 12	Random	32-40 %
Hot Band 3	7	70/30	See Table 12	Random	55-63 %
Hot Band 4	5	70/30	See Table 12	Random	80-88 %
NOTE "% of workload" is synonymous with Vdbench "skew" terminology.					

Table 11 - Workloads within the Hot Band IO Profile

7.3.8.3.4 Variable IO

The IO transfer (xfer) size used within the hot band IO profile is listed in Table 12 and Table 13.

Table 12 - IO Transfer Size within the Hot Band IO Profile for 512-Byte Native Devices

Xfer in KiB	Streaming Write	Streaming Read	Uniform	Hot Band
0.5			2%	2%
1			2%	2%
4	29%	29%	27%	27%
8	33%	33%	31%	31%
16	6%	6%	5%	5%
32	5%	5%	5%	5%
48			1%	1%
56			1%	1%
60			2%	2%
64	22%	22%	20%	20%
128	3%	3%	2%	2%
256	2%	2%	2%	2%

Xfer in KiB	Streaming Write	Streaming Read	Uniform	Hot Band
0.5				
1				
4	29%	29%	31%	31%
8	33%	33%	31%	31%
16	6%	6%	5%	5%
32	5%	5%	5%	5%
48			1%	1%
56			1%	1%
60			2%	2%
64	22%	22%	20%	20%
128	3%	3%	2%	2%
256	2%	2%	2%	2%

Table 13 - IO Transfer Size within the Hot Band IO Profile for 4-KB Native Devices

7.3.9 Test Sequence

All tests defined for a given taxonomy category shall be executed as an uninterrupted sequence, except as explicitly allowed by the execution requirements defined for a given test or test phase.

7.3.10 SUT Consistency

The physical and logical configuration of the SUT, including its configuration and tuning parameters, shall not be changed between or during a test or test phase unless explicitly allowed in the definition of the test or test phase.

7.3.11 No Non-Test Activity

Other than booting/starting the SUT and any test equipment employed during the benchmark, no substantive work shall be performed on the SUT between the tests or test phases defined in this specification, unless explicitly allowed in the definition of the test or test phase.

7.3.12 IO Modes

All IO requests on a SUT shall be classified as either:

- Foreground IO, an externally-initiated, application-level request for data transfer between the benchmark driver and the SUT, or;
- Background IO, a system-initiated request for data transfer within the SUT.

7.3.13 Average Response Time

The average response time for a test or test phase i, RTA_{*i*}(T), is calculated over a specified time interval T in seconds.

7.3.14 Average Power

The average power for a test or test phase *i*, $PA_i(T)$, is the arithmetic average of sampled power measurements taken over a specified time interval T in seconds, as illustrated in Equation 7-2.

Equation 7-2: Average Power

$$PA_i(T) = \frac{\sum W_s}{n}$$

Where:

- PA_i(T) is the average power during test or test phase *i*, taken over a time interval of T seconds;
- W_s is power in watts measured at each sampling interval *s* taken during the time interval T;
- *n* is the number of samples gathered by the power meter during the time interval T.

7.3.15 Operations Rate

The operations rate for a test or test phase *i*, $O_i(T)$, is a measure of the average rate of completed work over a specified time interval T. It is different for random workloads and sequential workloads. For random workloads (i.e., random read, random write and a mix of random read and random write), the operations rate is the average rate of IO operation completions during time interval T. For sequential workloads (i.e., sequential read or sequential write), the operations rate is the average rate of data transfer in MiB per second within time interval T. To provide a uniform basis for the metrics of a SNIA EmeraldTM Power Efficiency Measurement, these two different measures of operations rate are both represented by $O_i(T)$).

7.3.16 Periodic Power Efficiency

The periodic power efficiency for a test or test phase *i*, $EPP_i(T)$, is the ratio of operations rate over a specified time interval T and the average power during the same time interval T as illustrated by Equation 7-3.

Equation 7-3 : Periodic Power Efficiency

$$EPP_i(T) = \frac{O_i(T)}{PA_i(T)}$$

Where:

- EPP_i(T) is the periodic power efficiency during test or test phase *i*, taken over a time interval of T seconds;
- O_i(T) is the operations rate during test or test phase i, taken over the same time interval of T seconds;
- PA_{*i*}(T) is the average power during test or test phase *i*, taken over the same time interval of T seconds.

7.3.17 Measurement Interval

All tests and test phases state a minimum duration for their measurement interval. A measurement interval is a subset of a test or test phase during which the data underlying a specific metric or calculation is gathered.

A test sponsor shall ensure that a test's metric is stable throughout the measurement interval by analyzing the test output as specified in 7.3.18, and may have to extend some or all of SUT conditioning, tests or test phases to achieve stability of that test's metric.

7.3.18 Metric Stability Assessment

SUT metric M stability is assessed over the specified measurement interval defined in 7.3.17, where M represents a selected performance/watt metric (e.g., periodic power efficiency $EPP_i(T)$; see 7.3.16. Particular SUT test phases result in the generation of a continuous sequence of J fixed period samples of metric M values beginning after a specified warm-up period. The stability assessment evaluates a candidate sequence of K consecutive samples of metric M values where $K \le J$. The metric M sample period T is fixed by the SUT test; hence the measurement interval is equal to K * T (e.g. T = 60 seconds and K = 30 yielding a 30 minute measurement interval producing 30 samples of metric EPPi(60)). Each stability assessment must supply a value for K.

The stability of metric M is assessed by testing the flatness of the selected candidate sequence of K metric M values. It is recognized that this sequence, while otherwise flat, could have amplitude dispersal. Hence, the stability assessment is comprised of two tests:

- 1. A maximum allowed slope of a linear approximation of the K metric M values;
- 2. A smoothing function applied to the same K metric M values followed by comparison to a defined base reference value and a specified validity range.

The slope in (1) is determined from a least squares linear fit of the K metric M values.

The smoothing function in (2) consists of a weighted moving average S(M) of the same K metric M values. S(M) is based on a weighted average of present M and prior S(M) values.

The sequence of K metric M values must meet the stability requirements of both tests to be considered stable.

7.3.18.1 Assessment Method

Assessing the stability of metric M values consists of the following test flow:

- 1. Select the first sample immediately after the warm-up period and set this point as N = 0. There must be at least J = K metric M samples after this point.
- Perform both the least squares linear fit test on the (*M*_{N+1}..*M*_{N+K}) sequence as described in 7.3.18.2 and the weighted moving average test on the same (*M*_{N+1}..*M*_{N+K}) sequence as described in 7.3.18.3.
- 3. If either test fails, N is incremented and start again at (2) above as long as incremented N + K \leq J.
- 4. If full range J is exhausted without both tests passing, the metric M is deemed not stable.
- 5. If both tests pass, the metric M is deemed stable.

Once a stable sequence has been found, the assessment may optionally continue looking for more stable sequences by continuing to increment N until incremented N + K = J.

7.3.18.2 Least Squares Linear Fit Test

The least squares linear fit test is performed over the K metric M values ($M_{N+1}...M_{N+K}$). The least squares linear fit calculation over this sequence returns a fitted line slope value and an intercept value as shown in Equation 7-4.

Equation 7-4: Least Squares Linear Fit Calculation

$$Slope(M) = (\sum_{n=1}^{K} M_{N+n}(12n - 6K - 6))/(K(K - 1)(K + 1))$$
$$Int(M) = (\sum_{n=1}^{K} M_{N+n})/K - Slope(M)(K + 1)/2$$
$$Y = n * Slope(M) + Int(M)$$

Where:

- Slope(M) is the slope of the least squares fit line;
- Int(M) is the intercept of the least squares fit line;
- M_{N+n} is the *N*+*n*-th sample value of metric M.

To be stable, the value Y in Equation 7-4 of the least squares fit line at sample point n = K shall not be more than 5% different than the value Y in Equation 7-4 of the least squares fit line at sample point n = 1.

7.3.18.3 Weighted Moving Average Test

The weighted moving average test is performed over the K metric M values ($M_{N+1}...M_{N+K}$), as defined in Equation 7-5.

Equation 7-5: Weighted Moving Average Calculation

$$Base(M) = (\sum_{n=1}^{K} M_{N+n})/K$$

$$S_n(M) = wM_{N+n} + (1-w)S_{n-1}(M)$$
 for $n = 1..K$

$$S_0(M) = Base(M)$$

Where:

- Base(M) is the base reference value used to establish stability;
- M_{N+n} is the N+n-th sample value of metric M;
- S_n(M) is the *n*-th value of the weighted moving average of metric M;
- w is the factor that determines how much weight a new sample has in the moving average S_n(M) - each stability assessment must supply a value for w;
- S₀(M) is the initial value of the weighted moving average equation.

To be stable, each value of Sn(M) for n = 1..K shall differ from base reference Base(M) by no more than +/-5%.

7.4 Online and Near-Online Testing

7.4.1 Pre-fill Test

7.4.1.1 Overview

The SUT pre-fill test is intended to provide a working data set on the storage system to be used with the other testing sets.

7.4.1.2 Procedure

- The SUT shall have a minimum of 50% of the physical formatted storage pre-filled with the IO pattern described in Table 14 before continuing to the SUT Conditioning Test;
- The data used to pre-fill the SUT shall be a 2:1 compression pattern, when compressed by gzip (use the latest version and compression algorithm level 6--available at http://www.gzip.org/);
- Each IO stream shall issue each IO request synchronously, with each subsequent IO request issued immediately following the completion of its predecessor;
- The SUT pre-fill shall begin when the first request from the IO streams is issued by the benchmark driver;
- IO transfer size and alignment is picked by the test sponsor;
- The SUT pre-fill test shall last for at least the amount of time required to reach the pre-fill requirements of the SUT;
- The following test phases shall only access the allocated storage space that has pre-filled data.

IO Profile	Read/Write Percentage	IO Intensity	Access Pattern	Data Pattern
Sequential Write	0/100	100	Sequential	2:1 compression

Table 14 - Pre-fill Test IO Profile

7.4.2 SUT Conditioning Test

7.4.2.1 Overview

The SUT conditioning test is intended to provide a uniform initial condition for subsequent measurement(s) and to:

- Demonstrate the SUT's ability to process IO requests;
- Ensure that each storage device in the SUT is fully operational and capable of satisfying all supported requests within the constraints of the taxonomy classification identified for the SUT;
- Achieve typical operating temperature;
- Optionally, to provide a time period to allow the SUT to monitor/learn the characteristics of the workload and subsequent tiered storage data migration.

The limitations of timely benchmark execution make it impossible to remove all variability between results, or to provide complete pre-testing stability. Test sponsors are encouraged to minimize the impact of certain long-duration or infrequent changes to the SUT that can impact test results, including:

- Cache stability;
- Maintenance cycles.

7.4.2.2 Procedure

The SUT conditioning test shall begin when the first request from the IO streams is issued by the benchmark driver.

Each IO stream shall issue each IO request synchronously, with each subsequent IO request issued immediately following the completion of its predecessor.

The benchmark driver shall initiate a number of independent IO streams equal to or greater than the number of LUNS made available to the benchmark driver by the SUT.

Each IO stream shall issue a sequence of IO requests with the IO profile shown in Table 15.

IO Profile	Read/Write Percentage	IO Intensity	Access Pattern
Hot banding	See Table 11	100	See Table 11

Table 15 - Online and Near-Online Testing: SUT Conditioning Test IO Profiles

If the SUT includes functionality that requires changes to the IO profile defined in Table 15 in order to meet the intent stated in 7.4.2.1, the changes shall be disclosed.

The SUT conditioning test shall last for a minimum of 12 hours, any part of which may be optionally used for workload monitoring/learning of a tiered configuration.

7.4.2.2.1 Tiered Storage Configuration Data Migration Phase

If tiered storage is deployed, an optional migration phase may be included immediately following the monitoring/learning phase to allow data relocation into the appropriate tiers. The IO intensity during the migration phase shall be at least 25% per the IO profile defined in Table 15. If tiering is deployed, it shall be disclosed.

7.4.2.3 Data to be Collected

During the SUT conditioning test, the following data shall be collected at successive 1-minute intervals:

- Number of IOs issued;
- Average response time to complete an IO, RTA_{sc}(60) (see 7.3.13) reported to a precision of 1ms;
- The size in bytes of each IO issued;
- Average power, PA_{sc}(60) (see 7.3.14).

7.4.2.4 Validity

The SUT conditioning test shall satisfy the following conditions in order to be considered valid:

- All IOs issued shall complete successfully;
- During the final four hours of the SUT conditioning test, RTA_{sc}(14400) shall not exceed 20ms. This
 requirement does not apply to Near-Online systems.

7.4.3 Active Test

7.4.3.1 Overview

The active test collects data for test phases defined below.

The active test shall begin immediately following the SUT conditioning test.

7.4.3.2 Test Phases

Table 16 defines the sequence of test phases, and their associated IO profiles, for this test.

	IO Profile (Test Phase i)	IO Size (KiB)	Read/Write Percentage	IO Intensity	Transfer Alignment (KiB)	Access Pattern		
1	Hot Band Workload (i=HB) ^a	See Table 11	See Table 11	100	See Table 11	See Table 11		
2	Random Write (i=RW)	8	0/100	100	8	Random		
3	Random Read (i=RR)	8	100/0	100	8	Random		
4	Sequential Write (i=SW)	256	0/100	100	256	Sequential		
5	Sequential Read (i=SR)	256	100/0	100	256	Sequential		
a N	^a Near-Online system hot band workload may require further review.							

Table 16 – Online and Near-Online Testing: Active Test Phase IO Profiles

7.4.3.3 Procedure

The active test is composed of a set of test phases, which shall be executed as an uninterrupted sequence, in the order presented in Table 16.

Within the active test, each test phase shall begin when the first request from its IO streams is issued by the benchmark driver.

Each test phase shall launch a test-sponsor-selected number of independent IO streams.

Each IO stream shall issue its IO requests synchronously, with each subsequent IO request issued immediately following the completion of its predecessor. All IO operations shall transfer data, either reading or writing. The IO stream does not include any idle or "think time."

Each IO stream shall issue a sequence of IO requests matching the IO profile defined for the current test phase in Table 16.

Within the active test, each test phase shall last for a minimum of 40 minutes, comprised of a minimum 10 minute warm-up period followed by a minimum 30 minute measurement interval.

7.4.3.4 Data to be Collected

During a given test phase, the following data shall be collected at successive 1-minute (T = 60 second) intervals:

- Number of IOs issued;
- Average response time to complete an IO, RTA(60) (see 7.3.13 reported to a precision of 1ms;
- The size in bytes of each IO issued;
- Average power, PA,(60) (see 7.3.14);
- Operations rate, O_i(60) (see 7.3.15).

7.4.3.5 Validity

Each test phase execution shall satisfy the following conditions in order to be considered valid:

- The access pattern supplied by the benchmark driver shall match the IO profile selected for the test phase from Table 16;
- All IOs issued in a test phase complete successfully;
- The EPP₁(60) (see 7.3.16) shall be stable (see 7.3.18) throughout the measurement interval (see 7.3.17). The test sponsor may use any consecutive 30-minute interval that is found to be stable as the measurement interval for the purposes of calculating the primary metric for that phase (see

7.3.18). A value of 0.1 shall be used for the weighing factor w and a value of 30 shall be used for K in 7.3.14;

- Each RTA_{HB}(60), RTA_{RW}(60), and RTA_{RR}(60) within the measurement interval, shall not exceed 80 ms. This requirement does not apply to Near-Online systems;
- RTA_{HB}(1800), RTA_{RW}(1800) and RTA_{RR}(1800), based on the measurement interval, shall not exceed 20 ms. This requirement does not apply to Near-Online systems.

All COM functionality active during the capacity optimization test (see 7.4.5) may be disabled at the discretion of the test sponsor during the active test.

7.4.4 Ready Idle Test

7.4.4.1 Overview

The ready idle test collects data for the ready idle metric.

The ready idle test shall begin immediately following the active test.

7.4.4.2 Procedure

No foreground IO shall be initiated on the SUT during the ready idle test other than that required to satisfy the instrumentation requirements in 7.3.5.

The test sponsor may select the duration of the ready idle test, provided it is at least two hours. The test sponsor shall use the final two hours of the test as the measurement interval for the purposes of calculating the average power for the ready idle test primary metric (see 8.3.1).

7.4.5 Capacity Optimization Test

7.4.5.1 Overview

This section defines qualitative heuristics for validating the existence and activation of COMs that are present on the SUT. Each heuristic is a simple pass/fail test, intended only to verify the presence and activation of a particular capacity optimization method.

7.4.5.2 Testing Requirements

The heuristics assess the impact on free space to determine whether or not a COM is present and active. The assessments rely on:

- FS_{sot}: free space at the start of a test;
- FS_{eot}: free space at the end of a test;
- S_{ds}: size of a data set (see 7.4.5.3);
- I_{com} the impact of the COM on overall space utilization within the heuristic. The precise formulation of this value is defined by each heuristic.

Test sponsors may select which of the heuristics they wish to execute. Only heuristics which are executed can be marked as passed (see 8.6.1).

If test sponsors choose to execute a heuristic, they shall execute all of its steps in sequence. The testing of storage equipment may have minimal interruptions between heuristic COMs as needed to set up for each selected heuristic test. No configuration changes are allowed between each heuristic test.

No storage device may be added or removed, nor changed in state (taken on or offline, made a spare or incorporated, etc.) nor may any RAID groups be changed during any particular COM test. In the event of an automated disk failure and subsequent RAID rebuild at any time during a test, the test shall be restarted when the rebuild is completed and the failed disk replaced per manufacturers guidelines for installed and working systems.

Some of the following sections use the term "container" meaning a collection of logical blocks, e.g. a LUN.

7.4.5.3 Generating Data Sets

Most heuristics require the generation and use of specific data sets as part of their existence test. There are three different data set categories depending on the needs of the particular heuristic:

- Completely irreducible.
- Dedupable but not compressible;
- Compressible but not dedupable;

The required exclusivity of compressible and dedupable data sets comes from situations where certain systems may not have the ability to individually disable other COMs features during a particular heuristic test.

Each data set is to be approximately 2GB in size and shall be generated by com test data set generator available at <u>www.sniaemerald.com/download</u> with details in Table 17. Each data set will be created in a directory named "snia_capop_data". There are numerous files in each directory.

Category	File	Comments
Irreducible	irreducible.dat	Use different salt values if there is a need to use multiple irreducible data sets while avoiding duplicates.
Dedupable	dedupable.dat	Contains duplicated files of various size and duplicated blocks aligned on block boundaries. Also contains duplicated blocks of variable lengths not aligned on block boundaries. Allows detection of block-based schemes, variable-length schemes, and single-instance storage schemes.
Compressible	compressible.dat	For bit-level compression and pattern- oriented methods.

Table 17 - Data Sets	Table 17 - Da	ta Sets
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7.4.5.4 Delta Snapshot Heuristics

Delta snapshots in a storage system can be detected using a straightforward algorithm:

- 1. Query the free space before taking a snapshot.
- 2. Attempt to create a snapshot.
- 3. Write something to the snapshot in the case of a writeable one and then.
- 4. Query the free space after that snapshot to determine whether significant storage space has been used.

Read-only and writeable delta snapshots are treated separately so that systems that only do read-only snapshots may get credit for them.

7.4.5.4.1 Heuristic 1: Read-only delta snapshots

The method varies according to where the SUT places snapshots. Follow steps 1 or 2, and then proceed to step 3.

- 1. For a SUT that places snapshots in separate containers:
 - a. On the SUT, create two containers, each 15GB in size. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
 - b. Mount the first container on a host, via any chosen protocol.
 - c. Determine the amount of free space FS_{sot} available on the SUT as seen by the SUT.
 - d. Write the irreducible data set to the first container.
 - e. Perform a read-only delta snapshot of the first container and expose it through the second container, disabling any optional background copying mechanism. As an example, the snapshot of lun1 may be exposed as lun2.
 - f. Perform whatever steps are necessary to mount the second container as a file system. Open a small file on this file system (i.e., one of the files in the irreducible data set), read some data from it, and close the file. Confirm that the file has been successfully read.
- 2. For a SUT that places snapshots on the originating container:
 - a. On the SUT, create a container of 15GB in size. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
 - b. Mount the container on the host via any chosen protocol.
 - c. Determine the amount of free space FS_{sot} available on the container as seen by the SUT.
 - d. Write the irreducible data set to the container.
 - e. Perform a read-only snapshot of the container, disabling any optional background copying mechanism.
 - f. Perform whatever steps are necessary to mount the container as a file system. Open a file in the snapshot, read some data from it, and close the file. Confirm that the file portion has been successfully read.
- Determine the amount of free space, FS_{eot}, available on the container containing the snapshot as seen by the SUT. Calculate the space required for the snapshot I_{com} = FS_{sot} - FS_{eot}. If I_{com} is less than 2.5 GB, then the SUT passes the test.

7.4.5.4.2 Heuristic 2: Writeable delta snapshots

This method varies according to where the SUT places snapshots. Follow steps 1 or 2, and then proceed to step 3.

- 1. For a SUT that places snapshots in separate containers:
 - a. On the SUT, create two containers, each 15GB in size. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
 - b. Mount the first container on a host, via any chosen protocol.
 - c. Determine the amount of free space FS_{sot} available on the SUT as seen by the SUT.
 - d. Write the irreducible data set to the first container.

- e. Perform a writeable snapshot of the first container and expose it through the second container, disabling any optional background copying mechanism. As an example, the snapshot of lun1 may be exposed as lun2.
- f. Perform whatever steps are necessary to mount the second container as a file system. Open a small file on this file system (i.e., one of the files in the irreducible data set), write a few characters to it, and close the file. Confirm that the file has been successfully written with its new contents.
- 2. For an SUT that places snapshots on the originating container:
 - a. On the SUT, create a container of 15GB in size. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
 - b. Mount the container on the host via any chosen protocol.
 - c. Determine the amount of free space FS_{sot} available on the container as seen by the SUT.
 - d. Write the irreducible data set to the container.
 - e. Perform a writeable snapshot of the container, disabling any optional background copying mechanism.
 - f. Perform whatever steps are necessary to mount the container as a file system. Open a small file in the snapshot (i.e., one of the files in the irreducible data set), write a few characters to it, and close the file. Confirm that the file has been successfully written.
- 3. Determine the amount of free space FS_{eot} available on the container containing the snapshot as seen by the SUT. Calculate the space required for the snapshot $I_{com} = FS_{sot} FS_{eot}$. If I_{com} is less than 2.5 GB and the small file was successfully written onto the writeable delta snapshot destination, then the SUT passes the test.

7.4.5.5 Thin Provisioning Heuristics

The goal of this heuristic is not to highlight differences of thin provisioning implementations between vendors; it is to be used simply to ensure that the product under test does have some sort of thin provisioning capability.

A test sponsor seeking credit for thin provisioning shall:

- 1. Establish the total usable space or establish a pool of usable space as seen by the SUT.
- 2. Disable thin provisioning.
- 3. Request allocation of N LUNs of capacity M such that N*M is at least 20% greater than the total (or pooled) usable space. This shall result in an allocation error message.
- 4. Enable thin provisioning.
- 5. Request allocation of N LUNs of capacity M such that N*M is at least 20% greater than the total (or pooled) usable space. This shall result in an allocation of all requested LUNs.

Achieving the expected outcomes of items (3) and (5) results in the SUT passing the test.

7.4.5.6 Data Deduplication Heuristics

Data set size may not be important for the purposes of deduplication detection. However, larger data sets may be necessary to activate existing deduplication functionality. This heuristic allows the building of a larger data set, consisting of a single 2GB dedupable data set and the option of a test sponsor-determined integer number of 2GB irreducible data sets, collectively used to demonstrate deduplication capability. The addition of identical 2GB irreducible data sets can themselves be dedupable so it is a requirement to generate each with a different "salt" value.

A test sponsor seeking credit for deduplication of primary storage shall:

- 1. On the SUT, create a container large enough in size to engage the SUT deduplication mechanism. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
- 2. Perform whatever steps are necessary to make the container visible on the host from which tests are being run, and create and mount a local file system on that container.
- 3. Determine the amount of free space FS_{sot} available on the container as seen by the SUT.
- 4. For cases in which the 2GB dedupable data set is sufficient:
 - a) Write the 2GB dedupable data set to the container.
- 5. For cases in which a larger data set is required:
 - a) Establish the necessary data set size in 2GB increments;
 - b) Write the 2GB dedupable data set to the container;
 - c) In the same container, write as many instances of the 2GB irreducible data set as are required to meet system requirements for deduplication. For each:
 - i. Create a new directory for each data set;
 - ii. Invoke the gendddata tool on each directory with a different "salt" value each time (required);
 - iii. Delete the subdirectories containing the dedupable and compressible data sets so that only the irreducible data set remains;
 - iv. Copy the data set to the mounted file system on the SUT.
- 6. Wait a suitable amount of time as specified by the test sponsor for any non-inline deduplication processes to have completed.
- 7. Determine the amount of free space FS_{eot} available on the container as seen by the SUT.
- 8. Calculate the amount of formatted capacity saved by data deduplication $I_{com} = (1 ((FS_{sot} FS_{eot}) / S_{ds})) * 100\%$ where Sds is the size of the single dedupable data set. If I_{com} is greater than 10%, then the SUT passes the test.

7.4.5.7 Parity RAID Heuristics

Capacity utilization and improvement relative to a comparable RAID-1 configuration--the relative storage efficiency ratio--is simple to calculate, given that RAID group sizes and parity requirements are simple and well known.

A test sponsor seeking credit for parity RAID shall:

- 1. Choose a RAID group configuration. Use the option with the highest capacity utilization. For example, if a product supports RAID 5 and RAID 6, use the configuration whose default size gives the best relative storage efficiency ratio. It is mandatory to use the default RAID group size for the given configuration.
- Determine the number and capacity of the storage devices (e.g., hard disks) required to provision one RAID group of the default size for the system under test. Call the required number of drives D, and the number of parity drives P.
- Calculate I_{com} = (D P) / (D / 2). This is the relative storage efficiency of the RAID group compared to the assumed capacity utilization of a RAID-1 array configuration. The P value can be determined from Table 18. If I_{com} is greater than 1.0, then the SUT passes the test.

RAID Level	Parity (P value)
RAID-5	P=1
RAID-6	P=2

Table 18 - RAID and Parity	Settings
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7.4.5.8 Compression Heuristics

Data set size may not be important for the purposes of compression detection. However, larger data sets may be necessary to activate existing compression functionality. This heuristic allows the building of a larger data set, consisting of a single 2GB compressible data set and the option of a test sponsor-determined integer number of 2GB irreducible data sets, collectively used to demonstrate compression capability. The addition of identical 2GB irreducible data sets can themselves be dedupable so it is a requirement to generate each with a different "salt" value.

A test sponsor seeking credit for compression of primary storage shall:

- 1. On the SUT, create a container large enough in size to engage the SUT compression mechanism. The amount of actual physical storage that must be committed will vary by SUT, and should have been determined by the test sponsor in trials before an official run of the test.
- 2. Perform whatever steps are necessary to make the container visible on the host from which tests are being run, and create and mount a local file system on that container.
- 3. Determine the amount of free space FS_{sot} available on the container as seen by the SUT.
- 4. For cases in which the 2GB compressible data set is sufficient:
 - a) Write the 2GB compressible data set to the container.
- 5. For cases in which a larger data set is required:
 - a) Establish the necessary data set size in 2GB increments;
 - b) Write the 2GB compressible data set to the container;
 - c) In the same container, write as many instances of the 2GB irreducible data set as are required to meet system requirements for compression. For each:
 - i. Create a new directory for each data set;
 - ii. Invoke the gendddata tool on each directory with a different "salt" value each time (required);
 - iii. Delete the subdirectories containing the dedupable and compressible data sets so that only the irreducible data set remains;
 - iv. Copy the data set to the mounted file system on the SUT.
- 6. Wait a suitable amount of time as specified by the test sponsor for any non-inline compression processes to have completed.
- 7. Determine the amount of free space FS_{eot} available on the container as seen by the SUT.
- 8. Calculate the amount of formatted capacity saved by compression $I_{com} = (1 ((FS_{sot} FS_{eot}) / S_{ds})) * 100\%$ where Sds is the size of the single compressible data set. If I_{com} is greater than 10%, then the SUT passes the test.

7.5 Removable Media Library Testing

7.5.1 SUT Configuration

The SUT shall include the number of removable media drives given for the selected taxonomy category in Table 19. There shall be no change to the number of drives in the SUT during the tests.

Category	Required Drive Count
Removable-1	Maximum supported
Removable-2	Maximum Supported
Removable-3	Maximum Supported
Removable-4	24
Removable-5	24

Table	19 -	Required	Drive	Counts
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7.5.2 Pre-fill Test

There are no pre-fill requirements for removable media library testing.

All writes by the benchmark driver shall be 8-bit random data.

7.5.3 SUT Conditioning Test

7.5.3.1 Overview

The SUT conditioning test is intended to provide a uniform initial condition for subsequent measurement(s) and to:

- Demonstrate the SUT's ability to process IO requests;
- Ensure that each storage device in the SUT is fully operational and capable of satisfying all supported requests within the constraints of the taxonomy classification identified for the SUT;
- Achieve typical operating temperature.

The limitations of timely benchmark execution make it impossible to remove all variability between results, or to provide complete pre-testing stability. Test sponsors are encouraged to minimize the impact of certain long-duration or infrequent changes to the SUT that can impact test results, including:

- Cache stability;
- Maintenance cycles.

7.5.3.2 Procedure

Each IO stream shall issue each IO request synchronously, with each subsequent IO request issued immediately following the completion of its predecessor.

The SUT conditioning test shall begin when the first request from the IO streams is issued by the benchmark driver.

The benchmark driver shall uniformly distribute the required IO requests among the IO streams, such that the maximum number of IO requests serviced by an IO stream is no more than 10% greater than minimum number of IO requests serviced by an IO stream.

The test sponsor shall ensure that all tape/optical drives are accessed at some time during the SUT conditioning test.

The benchmark driver shall initiate a number of independent IO streams equal to or greater than the number of tape/optical drives made available to the benchmark driver by the SUT.

7.5.3.3 Phases

The SUT conditioning test shall consist of two phases, each lasting for a minimum of seven minutes. If the duration of either test phase is longer than the 7 minutes, the test sponsor shall designate the final 7 minutes of that test phase as the measurement interval for that test phase.

7.5.3.4 Tape/optical Drives

The test sponsor shall ensure that all tape/optical drives are:

- Loaded prior to the SUT conditioning test;
- Rewound between the two phases of the SUT conditioning test;
- Rewound at the end of the SUT conditioning test.

7.5.3.5 IO Profiles

Table 20 - Removable Media Library Testing: SUT Conditioning Test IO Profiles

IO Profile	IO Size (KiB)	Read/ Write Percentage	IO Intensity	Transfer Alignment (KiB)	Access Pattern
Sequential Write (i=C1)	256	0/100	100	256	Sequential
Sequential Read (i=C2)	256	100/0	100	256	Sequential

Each IO stream shall issue a sequence of IO requests satisfying the Sequential Write IO profile shown in Table 20 during the first phase of the SUT conditioning test, and the Sequential Read IO profile shown in Table 20 during the second phase of the SUT conditioning test.

If the SUT includes functionality that requires changes to the IO profile defined in Table 20 in order to meet the intent stated in 7.5.3.1, the changes shall be disclosed.

7.5.3.6 Data to be Collected

During the SUT conditioning test, the following data shall be collected at successive 1-minute intervals:

- Number of IOs issued;
- Average response time to complete an IO, RTA(60) (see 7.3.13), reported to a precision of 1ms;
- The size in bytes of each IO issued;
- Average power, PA₁(60) (see 7.3.14).

7.5.3.7 Validity

The SUT conditioning test shall be considered valid if all IOs issued in a test phase complete successfully.

7.5.4 Active Test

7.5.4.1 Overview

The active test shall begin immediately following the SUT conditioning test.

7.5.4.2 Procedure

Each test phase shall launch a number of independent IO streams equal to the number of drives present in the SUT. All drives in the SUT shall be capable of processing IO requests at the start of a test phase.

Each IO stream shall issue its IO requests synchronously, with each subsequent IO request issued immediately following the completion of its predecessor. All IO operations transfer data, either reading or writing. The IO stream does not include any idle or "think time."

Equation 7-6: Sequential Transfer Offset

$$O_{n+1} = (O_n + S) MOD R$$

Where:

- O_n is an IO offset;
- S is the IO size;
- R is the formatted capacity of the SUT.

7.5.4.3 Sequential Access

The first IO within a sequential IO Stream shall occur at Beginning of Tape (BOT). Each subsequent IO request shall be sent to and satisfied by the SUT in sequence using a transfer offset that satisfies Equation 7-6.

The benchmark driver shall uniformly distribute the required IO requests among the IO streams, such that the maximum number of IO requests serviced by an IO stream is no more than 10% greater than minimum number of IO requests serviced by an IO stream.

The test sponsor shall ensure that tape drives are accessed at some time during the active test.

IO Profile (Test Phase i)	IO Size (KiB)	Read/Write Percentage	IO Intensity	Transfer Alignment (KiB)	Access Pattern
Sequential Write (i=SW)	256	0/100	100	256	Sequential
Sequential Read (i=SR)	256	100/0	100	256	Sequential

 Table 21 - Removable Media Library Testing: Active Test Phase IO Profiles

Table 21 defines the sequence of test phases, and their associated IO profiles, used during this test.

Each IO stream shall issue a sequence of IO requests matching the profile defined for the current test phase in Table 21.

7.5.4.4 Test Phases

The active test is composed of two test phases, which shall be executed as an uninterrupted sequence, and separated by a rewind to Beginning of Tape (BOT), in the order presented in Table 21.

Within the active test, each test phase shall begin when the first request from its IO streams is issued by the benchmark driver.

Within the active test, the test sponsor may use any consecutive 30-minute interval, that is found stable as defined in 7.3.18, as the measurement interval, for the purposes of calculating the average power and operations rate for that phase. A value of 0.1 shall be used for the weighting factor w in Equation 7-5.

7.5.4.4.1 Data to be Collected

During a given test phase, the following data shall be collected at successive 1-minute (T = 60 second) intervals:

- Average data rate reported for each drive, reported in MiB/s;
- Average power, PA_i(60) (see 7.3.14);
- Operations rate, O_i(60) (see 7.3.15).

7.5.4.4.2 Validity

Each test phase execution shall satisfy the following conditions in order to be considered valid:

- All IOs issued in a test phase complete successfully.
- The access pattern supplied by the benchmark driver shall match the IO profile selected for the test phase from Table 21.
- The EPP (60) shall be stable (see 7.3.15 and 7.3.16), based on the 1-minute data collected according to 7.5.4.4.1, throughout the measurement interval.

7.5.4.5 Data Rate

The overall data rate for each drive used in a given configuration is defined to be the average of the average data rates collected for that drive according to 7.5.4.4.1.

The overall data rate for each drive present in the SUT for a given test phase shall be greater than or equal to 80% of the maximum published data rate for that drive type.

7.5.4.6 Tape Robots

If the SUT contains tape robots, they shall be enabled and ready to process a tape manipulation commands throughout the active test.

7.5.4.7 Drive-level Compression

If the SUT supports drive-level compression, it shall be disabled throughout the active test.

7.5.4.8 Timing Requirements

Not defined.

7.5.5 Ready Idle Test

The ready idle test shall begin immediately following the active test.

No foreground IO shall be initiated on the SUT during the ready idle test other than that required to satisfy the instrumentation requirements in 7.3.5.

Average power for this test phase is known as $PA_{RI}(60)$, as defined by Equation 7-2.

The test sponsor may select the duration of the ready idle test, provided it is at least than two hours. The test sponsor shall use the final two hours of the test as the measurement interval for the purposes of calculating the average power.

The ready idle test shall begin after any loaded storage devices have been unloaded from the tape drives and any robotics activity has completed.

7.5.6 Capacity Optimization Test

This specification does not define a capacity optimization method test for the Removable Media Library taxonomy category.

7.6 Virtual Media Library Testing

7.6.1 Pre-fill

There are no pre-fill requirements for removable media library testing.

All writes by the benchmark driver shall be 8-bit random data.

7.6.2 SUT Conditioning Test

7.6.2.1 Overview

The SUT conditioning test of a SNIA Emerald[™] Power Efficiency Measurement is intended to provide a uniform initial condition for subsequent measurement(s) and to:

- Demonstrate the SUT's ability to process IO requests;
- Ensure that each storage device in the SUT is fully operational and capable of satisfying all supported requests within the constraints of the taxonomy classification identified for the SUT;
- Achieve typical operating temperature.

The limitations of timely benchmark execution make it impossible to remove all variability between results, or to provide complete pre-testing stability test sponsors are encouraged to minimize the impact of certain long-duration or infrequent changes to the SUT that can impact test results, including:

- Cache stability;
- Maintenance cycles.

7.6.2.2 Procedure

Each IO stream shall issue each IO request synchronously, with each subsequent IO request issued immediately following the completion of its predecessor.

The SUT conditioning test shall begin when the first request from the IO streams is issued by the benchmark driver.

The benchmark driver shall uniformly distribute the required IO requests among the IO streams, such that the maximum number of IO requests serviced by an IO stream is no more than 10% greater than minimum number of IO requests serviced by an IO stream.

The test sponsor shall ensure that all storage devices are accessed at some time during the SUT conditioning test.

The benchmark driver shall initiate a number of independent IO streams equal to or greater than the number of virtual drives made available to the benchmark driver by the SUT.

7.6.2.3 Phases

The SUT conditioning test shall consist of two phases, each lasting for a minimum of 7 minutes. If the duration of either test phase is longer than the 7 minutes, the test sponsor shall designate the final 7 minutes of that test phase as the measurement interval for that test phase.

7.6.2.4 Virtual Drives

The test sponsor shall ensure that all virtual drives are:

- Loaded prior to the SUT conditioning test;
- Rewound between the two phases of the SUT conditioning test;
- Rewound at the end of the SUT conditioning test.

Table 22 - Virtual Media Library Testing: SUT Conditioning Test IO Profiles

IO Profile	IO Size (KiB)	Read/ Write Percentage	IO Intensity	Transfer Alignment (KiB)	Access Pattern
Sequential Write (i=C1)	256	0/100	100	256	Sequential
Sequential Read (i=C2)	256	100/0	100	256	Sequential

7.6.2.5 Sequence

Each IO stream shall issue a sequence of IO requests satisfying the Sequential Write IO profile shown in Table 22 during the first phase of the SUT conditioning test, and the Sequential Read IO profile shown in Table 22 during the second phase of the SUT conditioning test.

If the SUT includes functionality that requires changes to the IO profile defined Table 22 in order to meet the intent stated in 7.6.2.1, the changes shall be disclosed.

7.6.2.6 Data to be Collected

During the SUT conditioning test, the following data shall be collected at successive 1-minute intervals:

- Number of IOs issued;
- Average response time to complete an IO, RTA_i(60), reported to a precision of 1ms;
- The size in bytes of each IO issued;
- Average power, $PA_i(60)$ (see 7.3.14).

7.6.2.7 Validity

The SUT conditioning test shall be considered valid if all IOs issued in a test phase complete successfully.

7.6.3 Active Test

7.6.3.1 Overview

The active test shall begin immediately following the SUT conditioning test.

7.6.3.2 Procedure

During the active test, the SUT shall include a number of virtual drives that is sufficient to reach 80% of maximum published data rate for the drive type being emulated. There shall be no change to the number of virtual drives in the SUT between the sequential write and sequential read test phases.

Each test phase shall launch a number of independent IO streams equal to the number of virtual drives present in the SUT. All virtual drives in the SUT shall be capable of processing IO requests prior to the start of a test phase.

Each IO stream shall issue its IO requests synchronously, with each subsequent IO request issued immediately following the completion of its predecessor. All IO operations shall transfer data, either reading or writing. The IO stream does not include any idle or "think time."

7.6.3.3 Sequential Access

The first IO within an IO Stream shall use occur at Beginning of Tape (BOT). Each subsequent IO request shall be sent to and satisfied by the SUT in sequence using a transfer offset that satisfies Equation 7-7.

Equation 7-7: Sequential Transfer Offset

$$O_{n+1} = (O_n + S) MOD R$$

Where:

- O_n is an IO offset;
- S is the IO size;
- R is the formatted capacity of the SUT.

The benchmark driver shall uniformly distribute the required IO requests among the IO streams, such that the maximum number of IO requests serviced by an IO stream is no more than 10% greater than minimum number of IO requests serviced by an IO stream.

The test sponsor shall ensure that all storage devices that comprise the formatted capacity are accessed at some time during the active test.

7.6.3.4 Sequence

Table 23 – Virtual Media Library Testing: Active Test Phase IO Profiles

IO Profile (Test Phase i)	IO Size (KiB)	Read/Write Percentage	Transfer Alignment (KiB)	Access Pattern
Sequential Write (i=SW)	256	0/100	256	Sequential
Sequential Read (i=SR)	256	100/0	256	Sequential

Table 23 defines the sequence of test phases, and their associated IO profile for this test.

Each IO stream shall issue a sequence of IO requests matching the profile defined for the current test phase in Table 23.

7.6.3.5 Test Phases

The active test is composed of a set of test phases, which shall be executed as an uninterrupted sequence, separated by a rewind to Beginning of Tape (BOT), in the order presented in Table 23.

Within the active test, each test phase shall begin when the first request from its IO streams is issued by the benchmark driver.

Within the active test, the test sponsor may use any consecutive 30-minute interval, that is found stable as defined in Section 7.3.18, as the measurement interval, for the purposes of calculating the average power and operations rate for that phase. A value of 0.1 shall be used for the weighting factor w in Equation 7-5.

7.6.3.6 Data to be Collected

During a given test phase, the following data shall be collected at successive 1-minute (T = 60 second) intervals:

- Average data rate reported for each virtual drive in the SUT, reported in MiB/s;
- Average power, PA(60) (see 7.3.14);
- Operations rate, O_i(60) (see 7.3.15).

7.6.3.7 Validity

Each test phase execution shall satisfy the following conditions in order to be considered valid:

- All IOs issued in a test phase complete successfully;
- The access pattern supplied by the benchmark driver shall match the IO profile selected for the test phase from Table 23;
- The EPPi (60) shall be stable (see 7.3.15 and 7.3.16), based on the 1-minute data collected according to 7.6.3.6, throughout the measurement interval.

The overall data rate for each virtual drive used in a given test phase is defined to be the average of the average data rates collected for that drive according to 7.6.3.6.

Overall data rate for each virtual drive present in the SUT for a given test phase shall be greater than or equal to 90% of the maximum published data rate for the emulated drive type.

If the SUT supports drive-level compression, it shall be disabled throughout the active test.

7.6.3.8 Timing Requirements

Not defined.

7.6.4 Ready Idle Test

7.6.4.1 Overview

The ready idle test shall begin immediately following the active test.

7.6.4.2 Procedure

No foreground IO shall be initiated on the SUT during the ready idle test other than that required to satisfy the instrumentation requirements in 7.3.5.

Average power for this test phase is known as $PA_{RI}(60)$, as defined by Equation 7-2.

The test sponsor may select the duration of the ready idle test, provided it is at least than two hours. The test sponsor shall use the final two hours of the test as the measurement interval for the purposes of calculating the average power.

7.6.5 Capacity Optimization Test

This specification does not define a capacity optimization method test for the Virtual Media Library taxonomy category.

7.7 Adjunct Product Testing

7.7.1 Pre-fill Test

This specification does not define a pre-fill test for the Adjunct Product taxonomy category.

7.7.2 SUT Conditioning Test

This specification does not define a SUT conditioning test for the Adjunct Product taxonomy category.

7.7.3 Active Test

This specification does not define an active test for the Adjunct Product taxonomy category.

7.7.4 Ready Idle Test

This specification does not define a ready idle test for the Adjunct Product taxonomy category.

7.7.5 Capacity Optimization Test

This specification does not define a capacity optimization test for the Adjunct Product taxonomy category.

7.8 Interconnect Element Testing

7.8.1 SUT Conditioning Test

This specification does not define a SUT conditioning test for the Interconnect Element taxonomy category.

7.8.2 Active Test

This specification does not define an active test for the Interconnect Element taxonomy category.

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7.8.3 Ready Idle Test

This specification does not define a ready idle test for the Interconnect Element taxonomy category.

7.8.4 Capacity Optimization Test

This specification does not define a capacity optimization test for the Interconnect Element taxonomy category.

8 Metrics

8.1 Taxonomy Considerations

This specification defines metrics for the Online, Near-Online, Removable Media Library, and Virtual Media Library taxonomy categories only. Metrics for additional taxonomy categories may be defined in future revisions of the specification.

8.2 Primary Metrics

This specification defines the following primary metrics:

- Power efficiency for each test phase for Online and Near-Online systems (see 8.3):
 - EP_{HB} for Hot band
 - EP_{RR} for Random Read
 - EP_{RW} for Random Write
 - EP_{SR} for Sequential Read
 - EP_{SW} for Sequential Write
 - EP_{RI} for Ready Idle
- Power efficiency for each test phase for Removable Media Library systems (see 8.4):
 - EP_{SW} for Sequential Write
 - EP_{SR} for Sequential Read
 - EP_{RI} for Ready Idle
- Power efficiency for each test phase for Virtual Media Library systems (see 8.5):
 - EP_{SW} for Sequential Write
 - EP_{SR} for Sequential Read
 - EP_{RI} for Ready Idle

8.3 Power Efficiency Metric for Online and Near-Online Systems

8.3.1 Ready Idle Test

For the ready idle test, the power efficiency metric represents the amount of raw capacity supported per watt of power required by the SUT. It is calculated as shown in Equation 8-1, as the ratio of:

- The total raw capacity of the SUT, measured in GB;
- The average power, from the ready idle test, measured in watts.

Equation 8-1 Power Efficiency, Ready Idle

$$EP_{RI} = \frac{C_R}{PA_{RI}(7200)}$$

Where:

- EP_{RI} is the power efficiency metric for the ready idle test;
- C_R is the raw capacity of the SUT (see 4.2.24);
- PA_{RI}(7200) is the average power over the 2-hour measurement interval for the ready idle test.

8.3.2 Active Test

For each test phase of the active test, the power efficiency metric represents the rate of data transfer supported per watt of power required by the SUT during a selected stable measurement interval. It is calculated, as shown in Equation 8-2, as the ratio of:

- The operations rate, during the measurement interval of the active test, measured in IO/s or MiB/s;
- The average power, during the measurement interval of the active test, measured in watts.

Equation 8-2 Power Efficiency, Active

$$EP_i = \frac{O_i(1800)}{PA_i(1800)}$$

Where:

- EP_i is the power efficiency metric for Active Test test phase *i*;
- PA_i(1800) is the average power over the 30-minute measurement interval for Active Test test phase *i*;
- O_i(1800) is the operations rate over the 30-minute measurement interval for Active Test test phase *i*.

8.3.3 Reporting

The power efficiency metric shall be reported to three significant digits.

8.4 Power Efficiency Metric for Removable Media Library Systems

8.4.1 Ready Idle Test

For the ready idle test, the power efficiency metric represents the amount of raw capacity supported per watt of power required by the SUT. It is calculated as shown in Equation 8-1, as the ratio of:

- The total raw capacity¹ of the SUT, measured in GB;
- The average power, from the ready idle test, measured in watts.

¹ As tape cartridges themselves do not impact energy consumption, not all tape cartridges that could be present in a given configuration need to be present at the time of the test.

8.4.2 Active Test

For each test phase of the active test, the power efficiency metric represents the rate of data transfer supported per watt of power required by the SUT during a selected stable measurement interval. It is calculated, as shown in Equation 8-2, as the ratio of:

- The operations rate, during the measurement interval of the active test, measured in MiB/s;
- The average power during the measurement interval of the active test, measured in watts.

8.4.3 Reporting

The power efficiency metric shall be reported to three significant digits.

8.5 Storage Power Efficiency Metric for Virtual Media Library Systems

8.5.1 Ready Idle Test

For the ready idle test, the power efficiency metric represents the amount of raw capacity supported per watt of power consumed by the SUT. It is calculated as shown in Equation 8-1, as the ratio of:

- The total raw capacity of the SUT, measured in GB;
- The average power, from the ready idle test, measured in watts.

8.5.2 Active Test

For each test phase of the active test, the power efficiency metric represents the rate of data transfer supported per watt of power required by the SUT during a selected stable measurement interval. It is calculated, as shown in Equation 8-2, as the ratio of:

- The operations rate, during the measurement interval of the active test, reported in MiB/s;
- The average power during the measurement interval of the active test, measured in watts.

8.5.3 Reporting

The power efficiency metrics, when reported, shall be reported to three significant digits.

8.6 Secondary Metrics

8.6.1 Capacity Optimization Metrics

This specification defines capacity optimization tests for the Online and Near-Online taxonomy categories. The tests result in six binary, secondary metrics, which are given a value of 1 if the SUT satisfies the named COM heuristic, and 0 (zero) if it does not. The secondary metrics are:

- COM_{RD} based on the delta snapshots heuristic;
- COM_{WD} based on the delta snapshots heuristic;
- COM_{TP} based on the provisioning heuristic;
- COM_{DD} based on the data deduplication heuristic;
- COM_R based on the RAID heuristic;
- COM_c based on the compression heuristic.

This specification defines no relationship between the binary, secondary metrics defined in this section and the quantitative, primary metrics defined in 8.2.

Annex A. (informative) Suggested Power and Environmental Meters

A 1. Overview

The suggested meters for use in SNIA Emerald[™] Power Efficiency Measurements are the same as the list of devices approved for use with the SPEC power benchmark (<u>http://www.spec.org/power_ssj2008/</u>). For an expanded list of additional suggested meters, please refer to the SNIA Emerald web site, <u>http://sniaemerald.com/download</u>.

For more information on the appropriate use of a power meter in a SNIA Emerald[™] Power Efficiency Measurement, see 7.3.14. For more information on the selection criteria for power meters and the approval process for adding a new meter to this list, please contact the SNIA.

A 2. Alternate Meter Usage

Over time, the SNIA intends to revise the list of suggested meters to ensure that it remains current and comprehensive. It is possible for a test sponsor to submit a measurement that was taken using a meter not yet on the list ("alternate meter"). If a measurement uses an alternate meter, its submission must be accompanied with sufficient documentation about the meter and its configuration and calibration to ensure that its use provides measurement data equivalent to that provided by the recommended meters.

Test sponsors submitting a result using an alternate meter shall attest to its equivalence to the meters then on the recommended benchmark driver list in the following areas:

- Accuracy;
- Resolution;
- Calibration.

Annex B. (normative) Measurement Requirements

B1. Data Collection Requirements

A summary of the data collection requirements for the benchmark driver is provided in Table B-1.

	Collection Interval (seconds)		Minimum Benchr Driver Data Collection	nark	Minimum Test Duration (minutes)	
Test	Power Meter	Temp Meter	Online/ Near-Online	Removable/ Virtual	Online/ Near-Online	Removable/ Virtual
Conditioning	5	60	Response Time (per 1m interval)	Throughput (MiB/s)	720	7
Active	5	60	Response Time (per 1m interval)	Throughput (MiB/s)	40	30
Idle	5	60	N/A	N/A	120	120

Table B-1 Data Collection Summary